Searc	cn notes

Application/Control No	Applicant(s)/Patent unde Reexamination	r
10/708,834	BEENAU ET AL.	
Examiner	Art Unit	
Nam V. Nguyen	2635	

SEARCHED				
Class	Subclass	Date	Examiner	
340	5.53	5/22/2006	NN	
340	5.2	5/22/2006	NN	
340	5.4+	5/22/2006	. NN	
340	5.52	5/22/2006	NN	
340	5.6	5/22/2006	NN	
340	5.6+	5/22/2006	NN	
340	10.1\	5/22/2006	NN	
340	10.4-10.6	5/22/2006	NN	
235	379	5/22/2006	NN	
235	380	5/22/2006	NN	
235	492	5/22/2006	NN	
705	35,54,76	5/22/2006	NN	
705	185 ·	5/22/2006	NN	
705	194	5/22/2006	NN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Search: USPAT; US-PUB; EPO; JPO; and Derwent. (UPDATED SEARCH)	5/22/2006	NN
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